

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/516,404	DEMMER ET AI	L.
Examiner	Art Unit	
THANE LINDERDAHI	1651	

	SEARCHED		
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST-US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT	2/19/2008	TU		
Inventor Name Search for Double patenting in eDan	2/19/2008	TU		